



NCP170AXV360GEVB: Ultra Low IQ 150mA CMOS LDO Regulator Evaluation Board

The NCP170AXV360GEVB evaluation board is designed to quickly test the NCP170, a series of CMOS low dropout regulators are designed specifically for portable battery-powered applications which require ultra-low quiescent current. The ultra-low consumption of type 500nA ensures long battery life and dynamic transient boost feature improves device transient response for wireless communication applications.



Evaluation/Development Tool Information

Product	Status	Compliance	Short Description	Parts Used	Action
NCP170AXV360GEVB	Active	Pb-free	Ultra Low IQ 150mA CMOS LDO Regulator Evaluation Board	NCP170BXV330T2G	» Contact Local Sales Office

Technical Documents

Type	Document Title	Document ID/Size	Rev
Eval Board: BOM	NCP170AXV360GEVB Bill of Materials ROHS Compliant	NCP170AXV360GEVB_BOM_ROHS.pdf - 15 KB	0
Eval Board: Gerber	NCP170AXV360GEVB Gerber Layout Files (Zip Format)	NCP170AXV360GEVB_GERBER.zip - 32 KB	0
Eval Board: Schematic	NCP170AXV360GEVB Schematic	NCP170AXV360GEVB_SCHEMATIC.pdf - 54 KB	0
Eval Board: Test Procedure	NCP170AXV360GEVB Test Procedure	NCP170AXV360GEVB_TEST_PROCEDURE.pdf - 37 KB	0
Video	Ultra-Low IQ 150 mA CMOS LDO Regulator Evaluation Boards - NCP170	WVD17574/D	

Previously Viewed Products

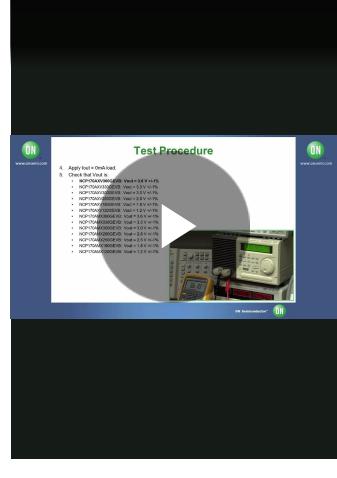
Select Product... Clear List

Design Support

- Technical Documentation
- Design Resources & Documents
- Technical Support
- Sales Support

Featured Video

Ultra-Low IQ 150 mA CMOS LDO Regulator Evaluation Boards - NCP170



[More Videos ...](#)